


<b>Search Notes</b>  	<b>Application/Control No.</b>  10512105	<b>Applicant(s)/Patent Under Reexamination</b>  VAN BEENEN, MARTIJN
	<b>Examiner</b>  Hsu, Amy	<b>Art Unit</b>  2622

SEARCHED			
Class	Subclass	Date	Examiner
348	373,375	9/14/07	ah
359	612,601,609,608		ah

SEARCH NOTES		
Search Notes	Date	Examiner
subclass search and text search	9/14/07	ah
update search	8/7/08	ah

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner